

### Description

The AO4612 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and

operation with gate voltages as low as 4.5V. This

device is suitable for use as a

Battery protection or in other Switching application.

#### **General Features**

V<sub>DS</sub> = 60V I<sub>D</sub> =8.5A

 $R_{DS(ON)} < 48m\Omega @ V_{GS}=10V$ 

V<sub>DS</sub> = -60V I<sub>D</sub> =-7.7A

 $R_{DS(ON)} < 85 \text{ m}\Omega @ V_{GS}=-10V$ 

#### Application

Wireless charging

Boost driver

Brushless motor

#### Package Marking and Ordering Information

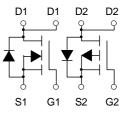
Product ID	Pack	Marking Qty(PC		
AO4612	SOP-8	4612XXX	3000	

### Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

	Barran	Rati	Units	
Symbol	Parameter	N-Channel	N-Channel P-Channel	
VDS	DS Drain-Source Voltage		-60	V
VGS	Gate-Source Voltage	±20	±20	V
I₀@T <sub>A</sub> =25℃	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	8.5	-7.7	А
I₀@T <sub>A</sub> =70°℃	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	4.0	-3	А
IDM	Pulsed Drain Current <sup>2</sup>	20	-14	А
EAS	Single Pulse Avalanche Energy <sup>3</sup>	22	28.8	mJ
IAS	Avalanche Current	21	-24	А
P <b>D@T</b> A=25℃	Total Power Dissipation <sup>4</sup>	2	2	W
TSTG	Storage Temperature Range	-55 to 150	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	-55 to 150	°C
R₀JA	Thermal Resistance Junction-Ambient <sup>1</sup>	85		°C <b>/W</b>
R₀JC	Thermal Resistance Junction-Case <sup>1</sup>	62.5		°C/W



SOP-8



N-Channel and P-Channel



Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BVDSS	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	60	65		V	
∆BVDSS/∆TJ	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C , I <sub>D</sub> =1mA		0.063		V/°C	
	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =10V , I <sub>D</sub> =5A		35	48	mΩ	
RDS(ON)		V <sub>GS</sub> =4.5V , I <sub>D</sub> =4A		41	65		
VGS(th)	Gate Threshold Voltage	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA	1.2	1.75	2.5	V	
$\bigtriangleup V_{\text{GS(th)}}$	$V_{GS(th)}$ Temperature Coefficient	VGS-VDS, ID -2500A		-5.24		mV/°C	
IDSS	Drain-Source Leakage Current	V <sub>DS</sub> =48V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			1		
1055		V <sub>DS</sub> =48V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C			5	uA	
IGSS	Gate-Source Leakage Current	V <sub>GS</sub> =±20V , V <sub>DS</sub> =0V			±100	nA	
gfs	Forward Transconductance	V <sub>DS</sub> =5V , I <sub>D</sub> =4A		28		S	
Qg	Total Gate Charge (4.5V)			19		nC	
Qgs	Gate-Source Charge	V <sub>DS</sub> =48V , V <sub>GS</sub> =4.5V , I <sub>D</sub> =4A		2.6			
Qgd	Gate-Drain Charge			4.1			
Td(on)	Turn-On Delay Time			3			
Tr	Rise Time Turn-Off Delay Time	V <sub>DD</sub> =30V , V <sub>GS</sub> =10V , R <sub>G</sub> =3.3Ω, I <sub>D</sub> =4A		34		ns	
Td(off)				23			
T <sub>f</sub>	Fall Time			6.0			
Ciss	Input Capacitance			1027			
Coss	Output Capacitance	V <sub>DS</sub> =15V , V <sub>GS</sub> =0V , f=1MHz		65		pF	
Crss	Reverse Transfer Capacitance			45			
IS	Continuous Source Current <sup>1,5</sup>	$V_G=V_D=0V$ , Force Current			2.5	Α	
VSD	VSD Diode Forward Voltage <sup>2</sup> V <sub>GS</sub> =0V , I <sub>S</sub> =1A , T <sub>J</sub> =25°C				1.2	V	

### N-Channel Electrical Characteristics (TJ =25 °C, unless otherwise noted)

Note :

1. The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.

 $2\,{\scriptstyle \sim}\,$  The data tested by pulsed , pulse width  $\leq 300 us$  , duty cycle  $\leq 2\%$ 

3. The power dissipation is limited by 150°C junction temperature

4. The data is theoretically the same as I D and I DM, in real applications, should be limited by total power dissipation



Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BVDSS	Drain-Source Breakdown Voltage	ge V <sub>GS</sub> =0V , I <sub>D</sub> =-250uA		-65		V	
∆BVDSS/∆TJ	$DSS/\Delta TJ$ BV <sub>DSS</sub> Temperature Coefficient Reference to 25°C , I <sub>D</sub> =-1mA			-0.03		V/°C	
RDS(ON)	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =-10V , I <sub>D</sub> =-3A		72	85	mΩ	
RD3(ON)		V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-2A		100	105	11122	
VGS(th)	Gate Threshold Voltage	$V_{GS}$ = $V_{DS}$ , $I_D$ =-250uA	-1.2	1.75	-2.5	V	
	Drain-Source Leakage Current	V <sub>DS</sub> =-48V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			1	uA	
IDSS		V <sub>DS</sub> =-48V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C			5		
IGSS	Gate-Source Leakage Current	$V_{GS}$ =±20V , $V_{DS}$ =0V			±100	nA	
gfs	fs Forward Transconductance V <sub>DS</sub> =-5V , I <sub>D</sub> =-3A			8.5		S	
Qg	Total Gate Charge (-4.5V)			12.1			
Qgs	Gate-Source Charge	V <sub>DS</sub> =-48V , V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-3A		2.2		nC	
Qgd	Gate-Drain Charge			6.3			
Td(on)	Turn-On Delay Time			9.2			
Tr	Rise Time	V <sub>DD</sub> =-15V , V <sub>GS</sub> =-10V ,		20.1			
Td(off)	Turn-Off Delay Time	R <sub>G</sub> =3.3□, I <sub>D</sub> =-1A		46.7		ns	
T <sub>f</sub>	Fall Time			9.4			
Ciss	Input Capacitance			1137			
Coss	Output Capacitance	V <sub>DS</sub> =-15V , V <sub>GS</sub> =0V , f=1MHz		76		pF	
Crss	Reverse Transfer Capacitance			50			
IS	Continuous Source Current <sup>1,5</sup>	$V_G=V_D=0V$ , Force Current			-2.5	Α	
VSD	VSD Diode Forward Voltage <sup>2</sup> V <sub>GS</sub> =0V , I <sub>S</sub> =-1A , T <sub>J</sub> =25°C				-1.2	V	

### P-Channel Electrical Characteristics (TJ =25 °C, unless otherwise noted)

Note :

1、The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.

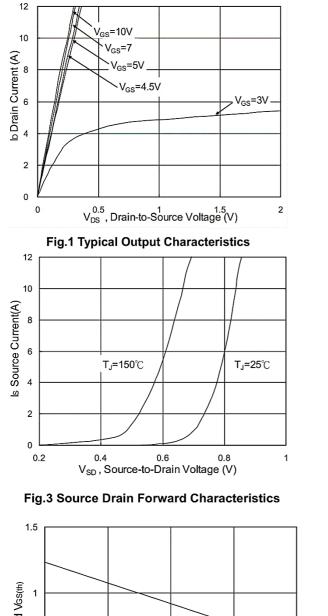
2、 The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%

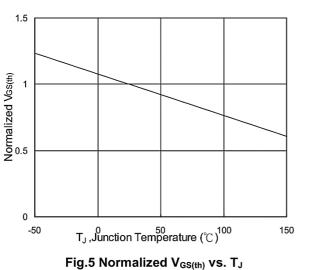
3. The power dissipation is limited by 150°C junction temperature

4、The data is theoretically the same as I D and I DM , in real applications , should be limited by total power dissipation.



# **N-Channel Typical Characteristics**





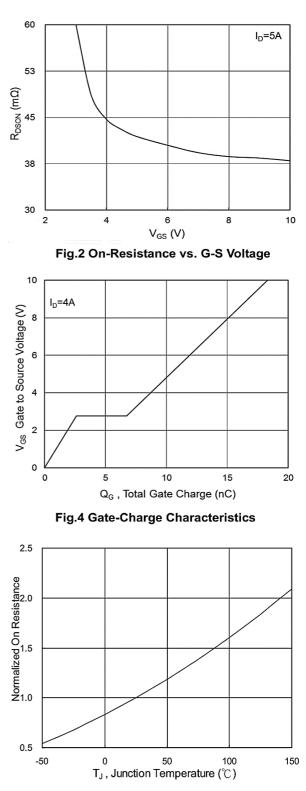
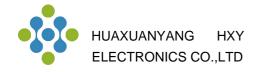


Fig.6 Normalized R<sub>DSON</sub> vs. T<sub>J</sub>



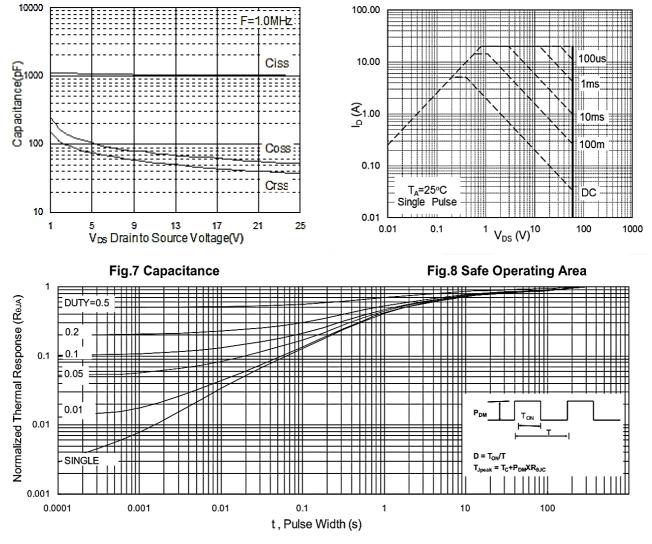


Fig.9 Normalized Maximum Transient Thermal Impedance

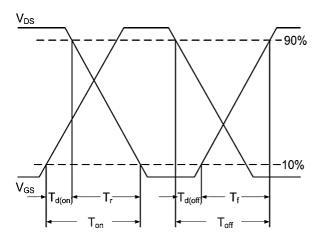
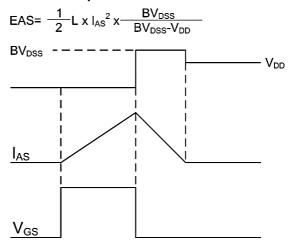
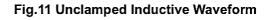


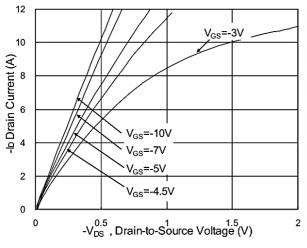
Fig.10 Switching Time Waveform







#### P-Channel Typical Characteristics



**Fig.1 Typical Output Characteristics** 

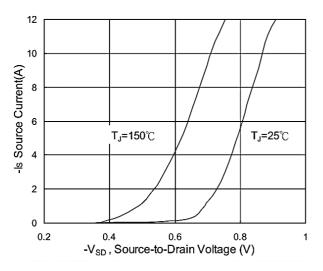
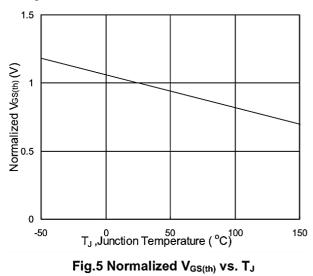


Fig.3 Source Drain Forward Characteristics



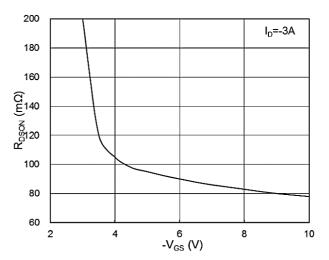


Fig.2 On-Resistance vs. G-S Voltage

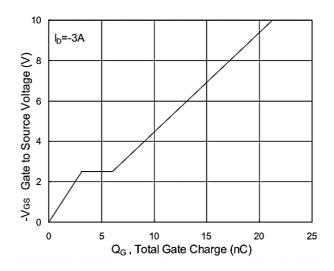


Fig.4 Gate-Charge Characteristics

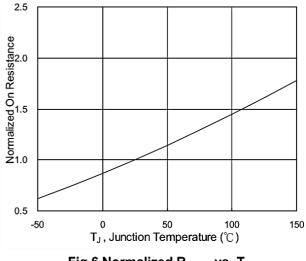


Fig.6 Normalized R<sub>DSON</sub> vs. T<sub>J</sub>



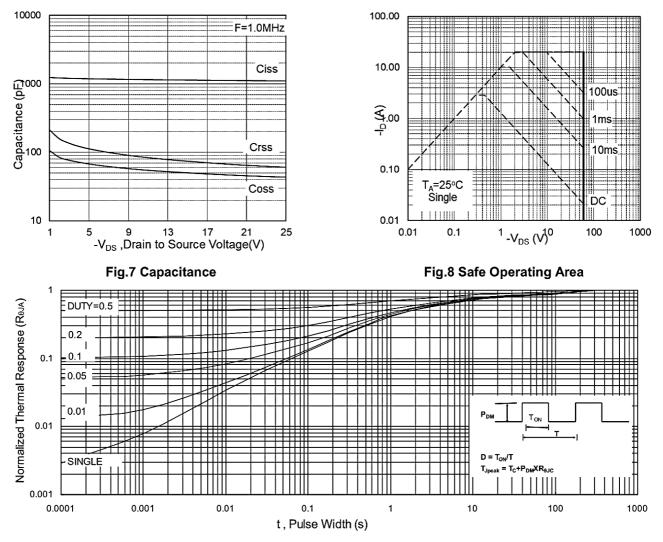


Fig.9 Normalized Maximum Transient Thermal Impedance

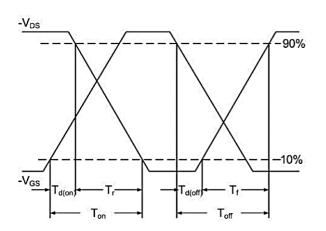
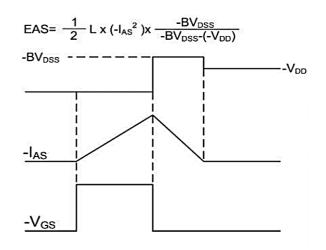
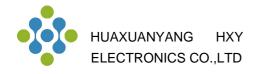


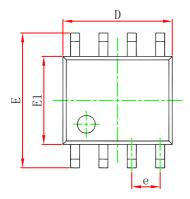
Fig.10 Switching Time Waveform

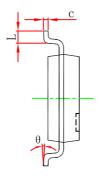


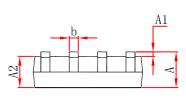




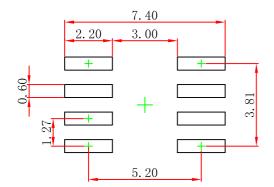
# **SOP-8 Package Outline Dimensions**







Symbol	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min	Max	Min	Max	
Α	1.350	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
с	0.170	0.250	0.007	0.010	
D	4.800	5.000	0.189	0.197	
e	1.270 (BSC)		0.050 (BSC)		
E	5.800	6.200	0.228	0.244	
E1	3.800	4.000	0.150	0.157	
L	0.400	1.270	0.016	0.050	
θ	0 °	8°	0 °	8°	



Note: 1.Controlling dimension: in millimeters.

2.General tolerance:± 0.05mm.
 3.The pad layout is for reference purposes only.



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